

FROM SENSOR TO DETECTOR WITH SOME OBSTACLES

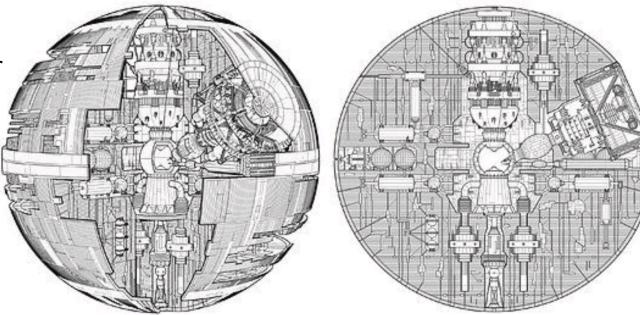
11th Beam Telescopes and Test Beams Workshop 17-21 April 2023

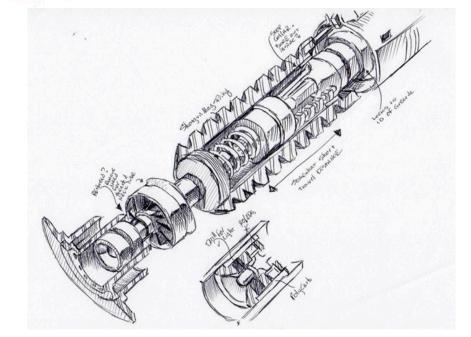
Ingrid Maria Gregor DESY/Universität Bonn

INTRODUCTION

- Designing a particle physics (tracking) detector is a very complex business
- Many very nice examples exist
- Also some examples of failures
- Today: overview of main steps to get from sensor to detector
- Some examples where problems appeared

A topic to talk hours about. Some bias in the selection of detectors and examples based on my experience, my friends and other factors ...







THE MAIN STEPS

VI HOVET, S, C

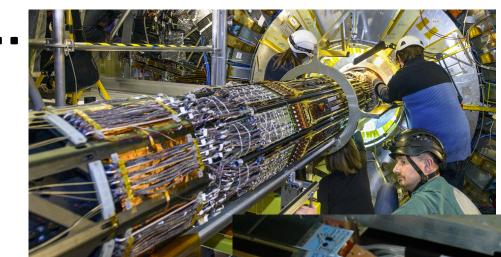
600

3

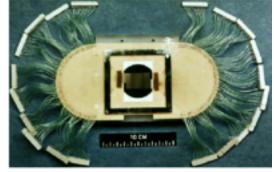
WHAT WE WANT



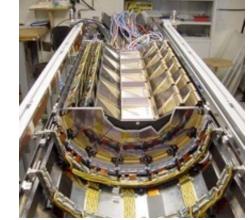
CMS Strip Detector, 2007



ATLAS Pixel Detector 2007

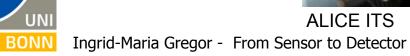


NA11 1981





Belle II PXX, 2022



DELPHI VFT 1996

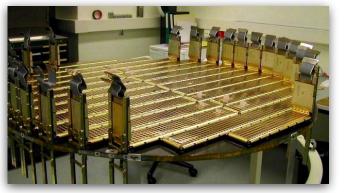




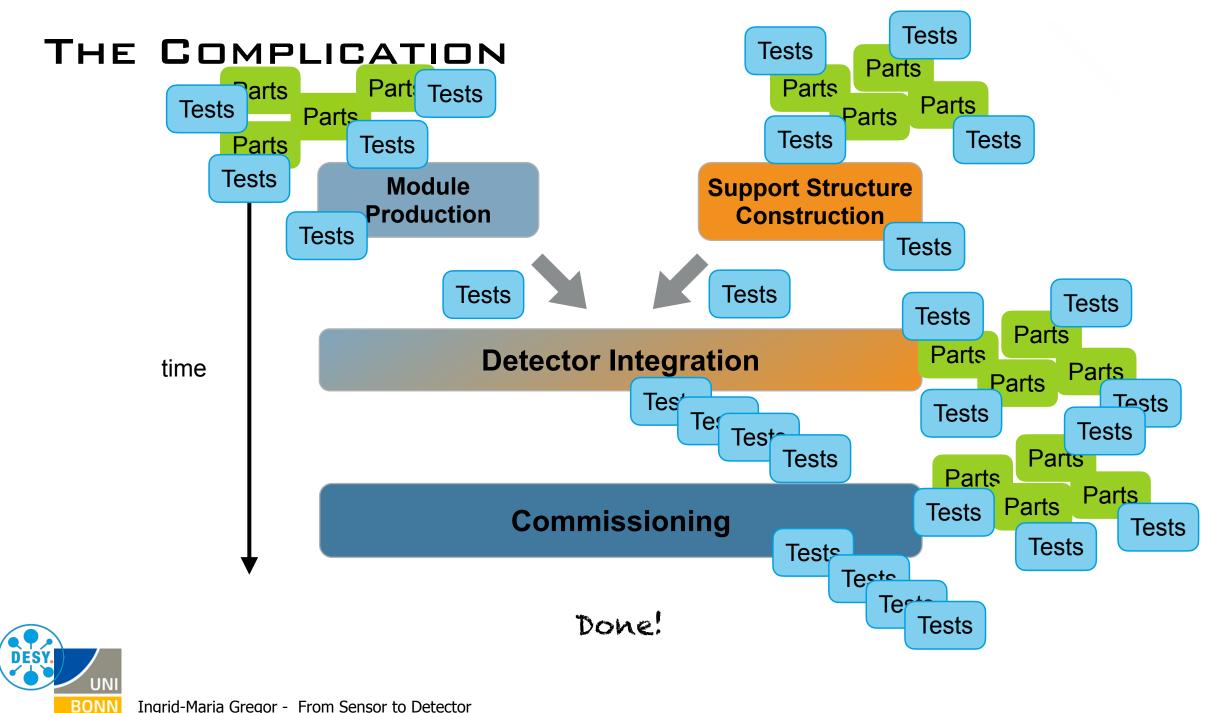




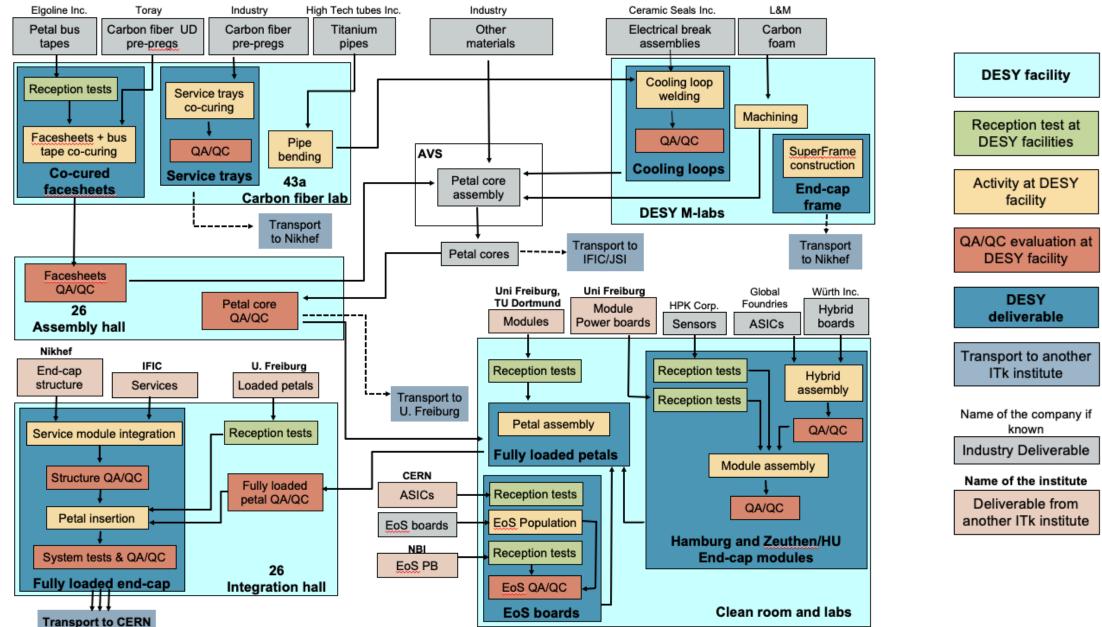
ZEUS MVD 2000



AMS Strip Detector,



ATLAS END-CAP WORKFLOW AT DESY



DESY.

6

DESY

Cornell

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DESY.

MODULE PRODUCTION

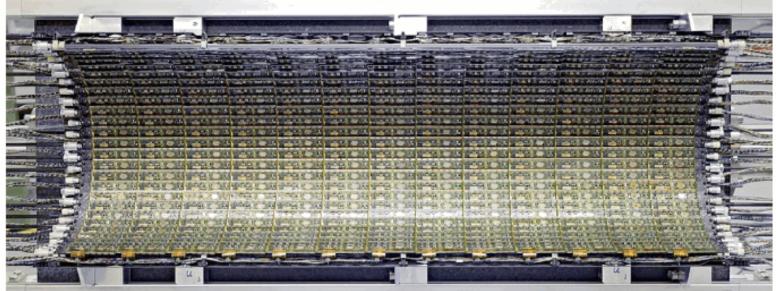
VI FIDET, S, C

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THE MODULE

- Module
 - Smallest building block to be mounted to support structure
 - Sensor plus readout electronics
 - Maybe some powering electronics and interfaces
- The detector can only be as good as its smallest parts
- Module quality defines detector quality (to some extent)
- Large share of production time is dedicated to module production

Project	CMS Pixel Phase I	LHCb Velo	DØ Microst rip Tracker	ATLAS ITk Strips	Belle II
#	1 856	42	672	17 888	40





ATLAS Pixel Detector

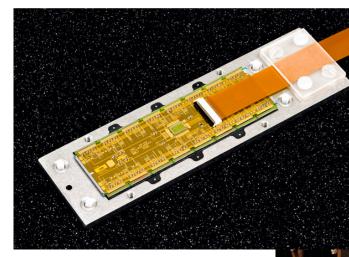
THE MODULE

Module

Smallest building block to be mounted to support structure

LHCb Velo

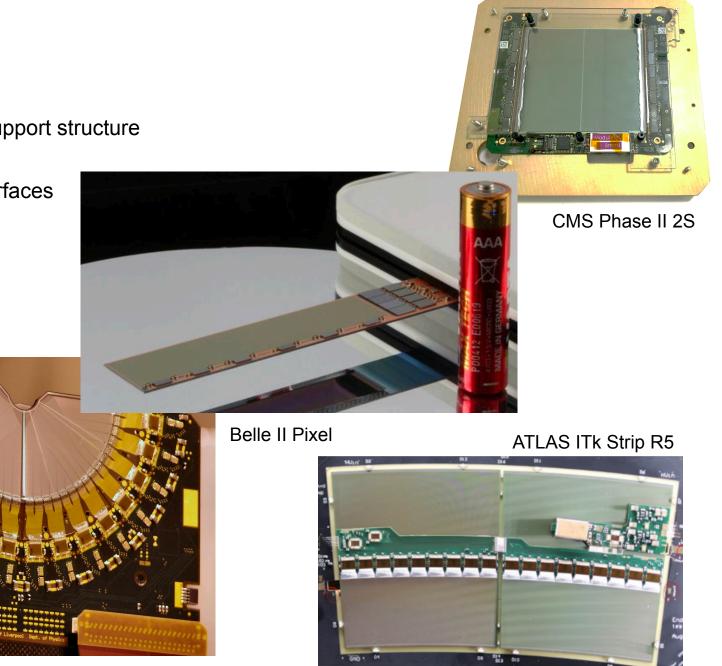
- Sensor plus readout electronics
- Maybe some powering electronics and interfaces



CMS Phase I Pixel







MODULE CONCEPTS

Pixel

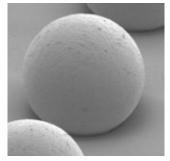
see Dominik Dannheim

- Hybrid with
 - Bump bonds
 - Wafer to wafer
 - Capacitive coupling

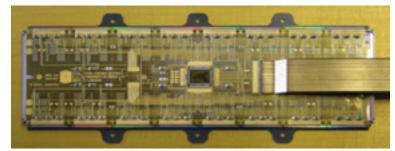
Monolithic

Independent of hybrid or monolithic: Need connection to outside world!

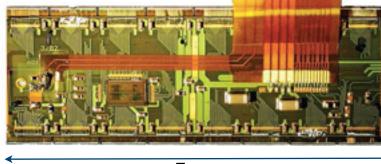
Typically flexible circuit board placed on top or below and connected via wire-bonds



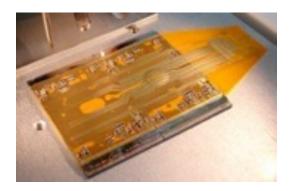
Bump-bonds -> see backup



CMS pixel module

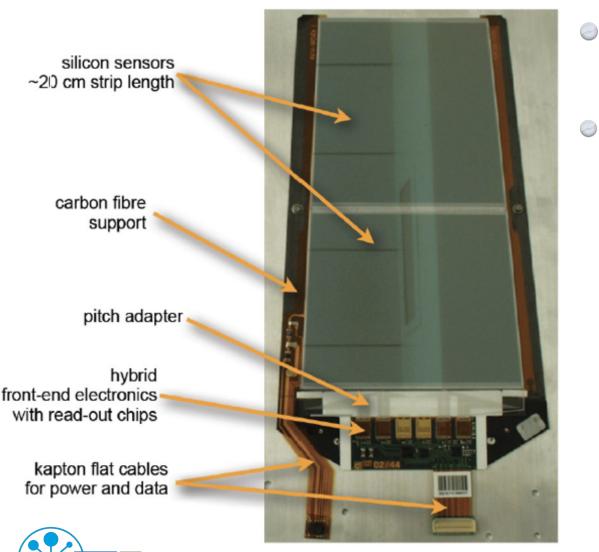


7 cm ATLAS pixel module



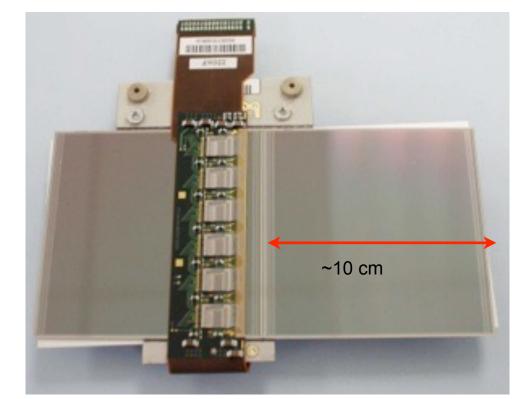
ATLAS quad module (early version)

MODULE CONCEPTS



Strips

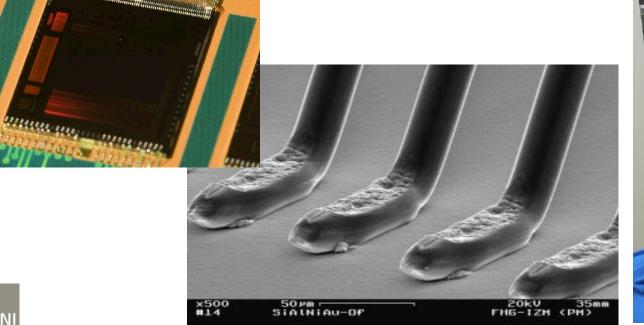
- Classic hybrid with wire-bonds
- Monolithic future dream
- FE chips wire bonded to large strip sensor

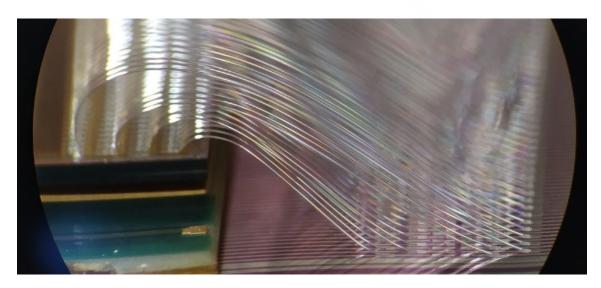


ATLAS strip barrel module

WIRE BOND CONNECTION

- Ultrasonic welding technique
 - typically 25 micron bond wire of Al-Si-alloy
- Nowadays: Fully-automatised system with automatic pattern recognition





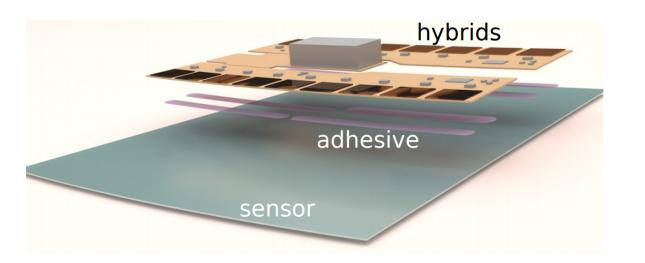




BUILDING MODULES (EXAMPLE STRIPS)

Before production:

define specifications for module (quality)



To be defined:

- Sensor IV, CV, etc
- Sensor bow
- Chip on wafer tests
- Hybrid noise performance
- Wire bonds strength
- Electrical performance
- Full module: metrology
-

many years of R&D

- defect

- good die

- defective die

- partial edge die

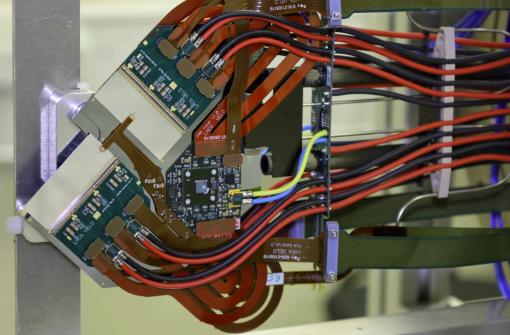
based on

Exploded view ATLAS ITk Strips module

- Understanding the yield:
 - yield: the (expected) fraction of parts surviving tests during production
 - relying on very high yield
 - example: 20 steps with yield of 98%
 -> only 66% of sensors go into experiment

BUILDING MODULES

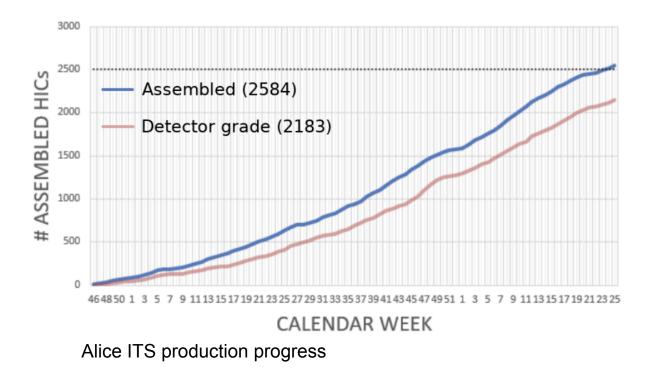
- For large detectors many things to be taken into account to set up module
 - Avoid single vendors!!!
 - Try to have as many parts as possible "off the shelf"
 - Where possible stay within industry standards
 - Reduce manual steps and make every thing as simple as possible





LHCb Velo Pixel

Nice videos: <u>https://www.youtube.com/watch?</u> <u>v=Vo4tvenA4rQ</u> (Belle II) <u>https://www.youtube.com/watch?</u> <u>v=fV5SiKzZ8M8</u> (ATLAS)



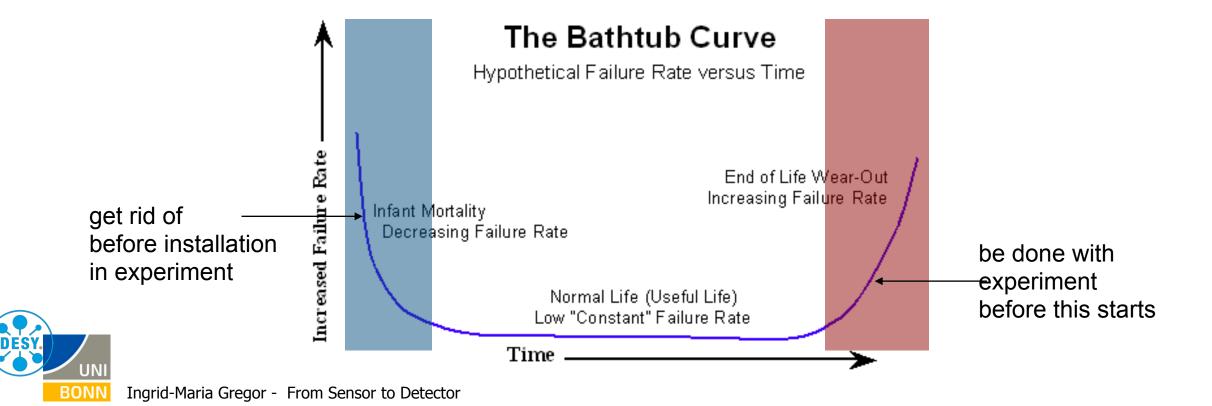
BUILDING MODULES

Ouring production:

- Perform fast checks on every single module automation
- Provide feedback for construction
- Classify & reject modules
- Store results data base

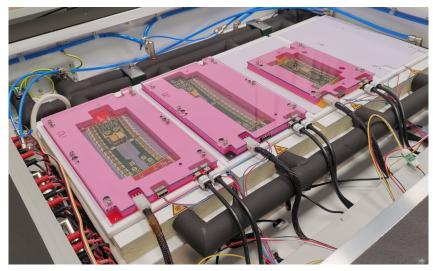
Fun fact!

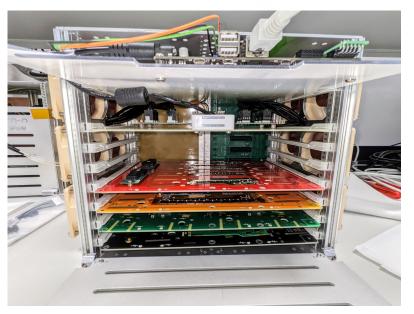
	ATLAS	CMS
R&D parts and samples		
during production -	QA	QC
possibly up to destruction	Quality assurance	Quality control
Checks of every single production part	QC Quality control	QA Quality assurance



CHECKS DURING PRODUCTION

- Most checks during production are performed at room temperature
- Detectors are often operated at low temperatures (down to -30C)
- Test detectors at high and low temperatures
 - Test response to thermal cycling
- Burn-In: thermal cycling with tests at extreme temperatures
 - Trigger & identify thermal stress
 - Overcome infant mortality
 - Calibration





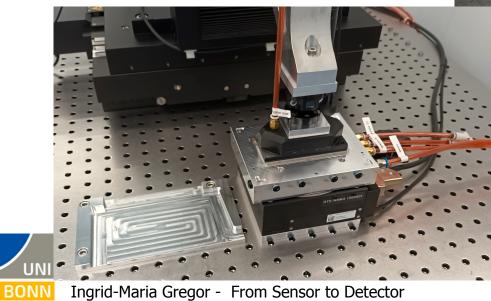
Hybrid burn-in test

Setup for module thermal cycling - 3 modules simultaneously tested

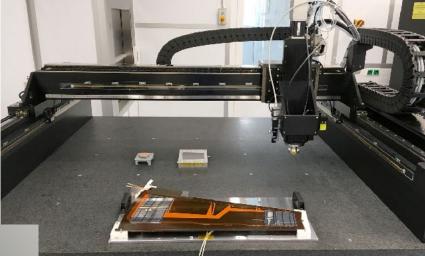


Robots

- During production need to limit manual steps
- By now all automated machines are available
- Industrial solutions
 - Wire-bonder
 - Gluing robot
- Home-made developments
 - Module loading (based on gantry)
 - Bustape testing
- Very attractive tasks for detector R&D newcomers







Module gluing and placing tool (ATLAS)

Module construction robot (CMS)



Gluing robots



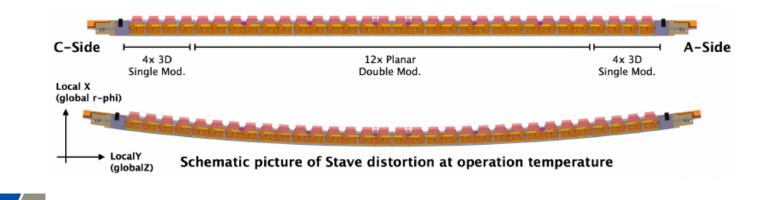
Testing robot (ATLAS)

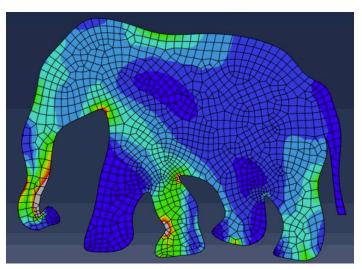
(LOCAL) SUPPORT PRODUCTION

AND TESTING

SUPPORT STRUCTURE

- Sounds simple:
 - Something to put modules and cables on that keeps the active components cold and in position
- Years of engineering and design effort, because they require ...
 - Incredibly high precision over large areas
 - Stability (mechanical, thermal & thermo-mechanical)
 - To be customised to module design
 - Best made without material
 - Radiation tolerance (if needed)
- To be transportable





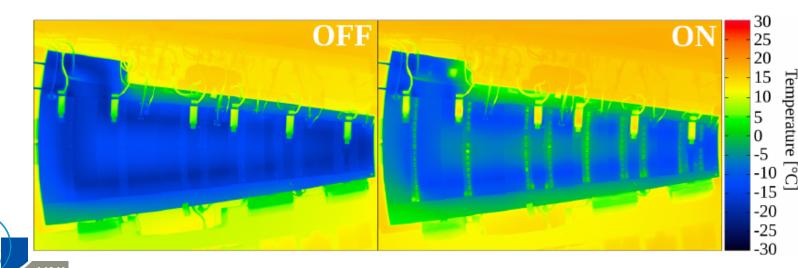
Finite element analysis (FEA) vital for a good detector.

Work very often seen as "non-scientific"

- which is certainly NOT true

MORE QUALITY TESTS NEEDED

- One of the main challenges for large systems: maintain good flatness over large areas
- Measurement: e.g. via metrology arm
- Well define and design construction processes
- QA of cooling performance: coping with heat dissipation of modules & temperature stability/homogeneity
- Typical method: Infrared thermography





CMS Outer Tracker

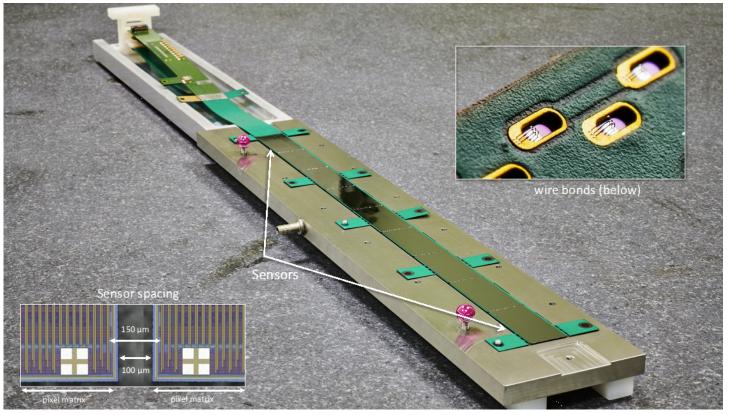
"INTEGRATION"

VI FIDET, S, C

Maybe most used word for different steps

MODULE ONTO LOCAL SUPPORT

- Depending on size and amount of modules, a manual approach is probably not recommendable
- Many tools to be designed
- Precision placement needed
- Modules need to be attached (glue)
- Possibly use of robots!



Ladder of ALICE ITS Pixel

UNI BONN Ingrid-Maria Gregor - From Sensor to Detector

Semi-electrical petal @ DESY Loading of petal core 07 - back side

Video: Othmane Rifki, 2017

DESY INTEGRATION

- Detector Integration: Integration of detector modules & support structure
 - Extremely delicate task
 - Handling many certified functional components at the same time
 - Unwieldy in case of small or large systems (either delicate and compact or hard to reach)
 - → Proper tooling required!



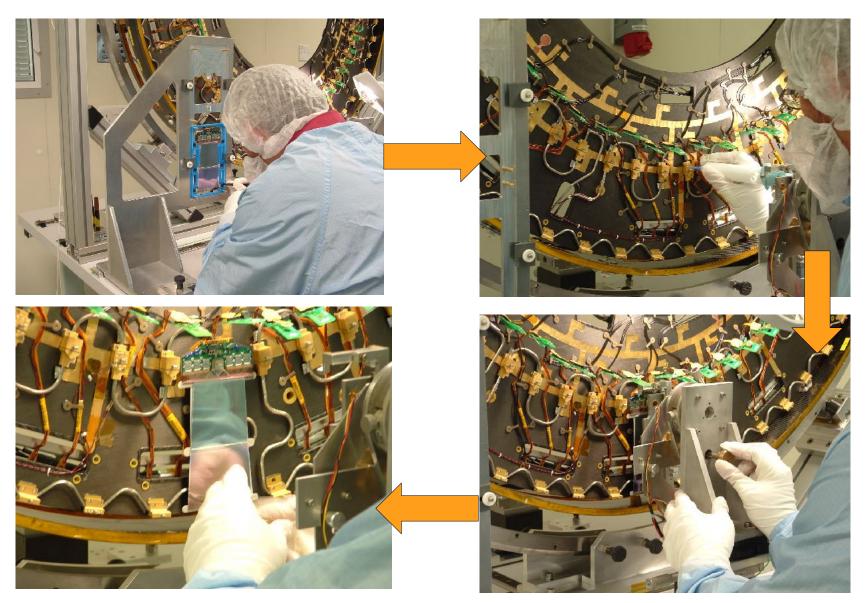
CMS Pixel Phase I



LHCb Velo



FROM MODULE TO DETECTOR

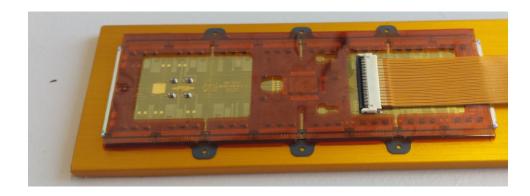


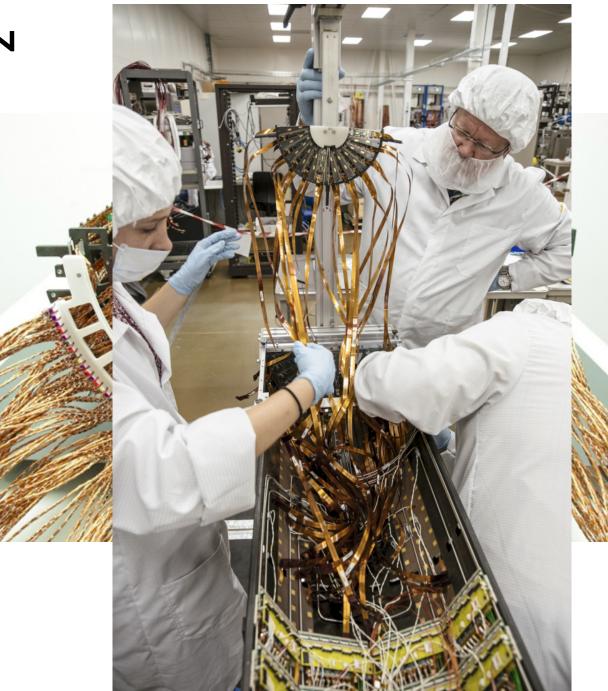


DETECTOR INTEGRATION

CMS Phase I Pixel Barrel

- Half barrel: 592 modules,
 - \sim 1 year of module production
- Delicate placing & mounting of modules
- Always label your cables …

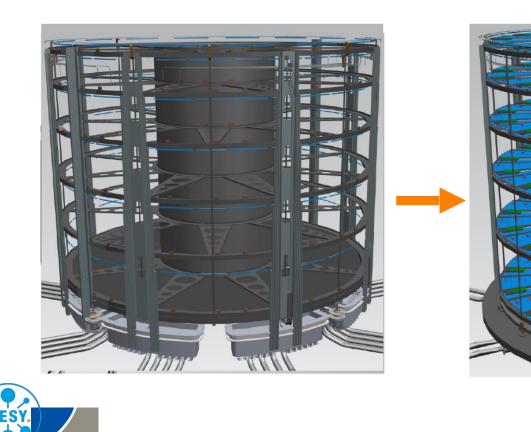


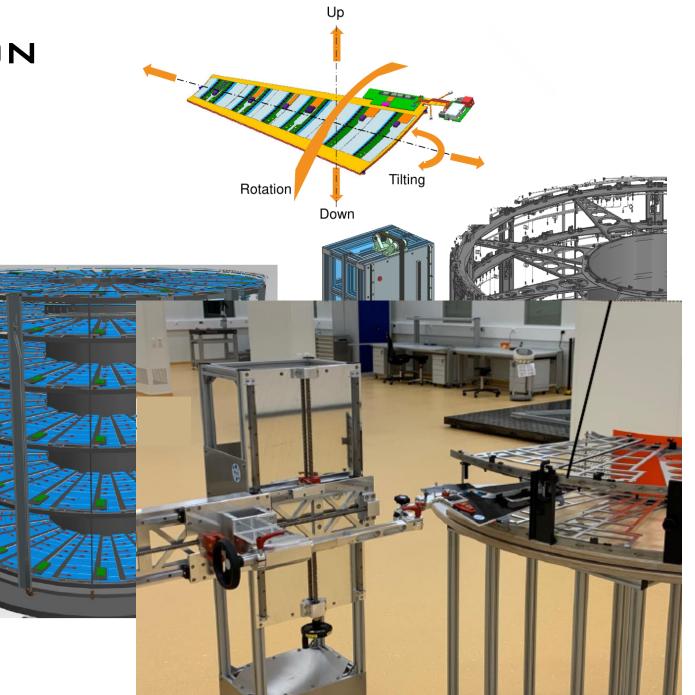




FILLING THE SKELETON

- Example: ATLAS ITk Strips
- Tools designed to do all steps
- Here: tool to insert petals into skeleton





SILICON TRACKER (SCT)





Ingrid-Maria Gregor - From Sensor to Detector

Insertion of the 3rd cylinder (out of the four) into the barrel SCT

TRANSPORTATION

VI FIDET, S, C

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GETTING (LARGER) PARTS TO DESTINATION

- Distributed construction of modules, detectors & components requires transportation
- Sensors, Chips, Cables, Connectors, ...: parcel shipment
- Modules: parcel shipment or custom transportation
 - Mounted on carriers
- Full detectors: very special needs





Paul Schütze with 300 CMS Phase I Pixel Detector Modules (selfie)





Belle II PXD2 flying business class

COMPLETELY DIFFERENT REQUIREMENTS

- AMS experiment needed a rocket to get inserted
- Acceleration during start/ landing up to 9g



On ground transport requirements <2g due to ramped-up magnet

GETTING THE DETECTOR SAFELY TO EXPERIMENT





INSTALLATION

VI FILLET, S, C

600

BIG TOOLS ARE NEEDED!!

Nice video: <u>https://www.youtube.com/watch?v=NEpfljUk9sk</u> ATLAS Pixel



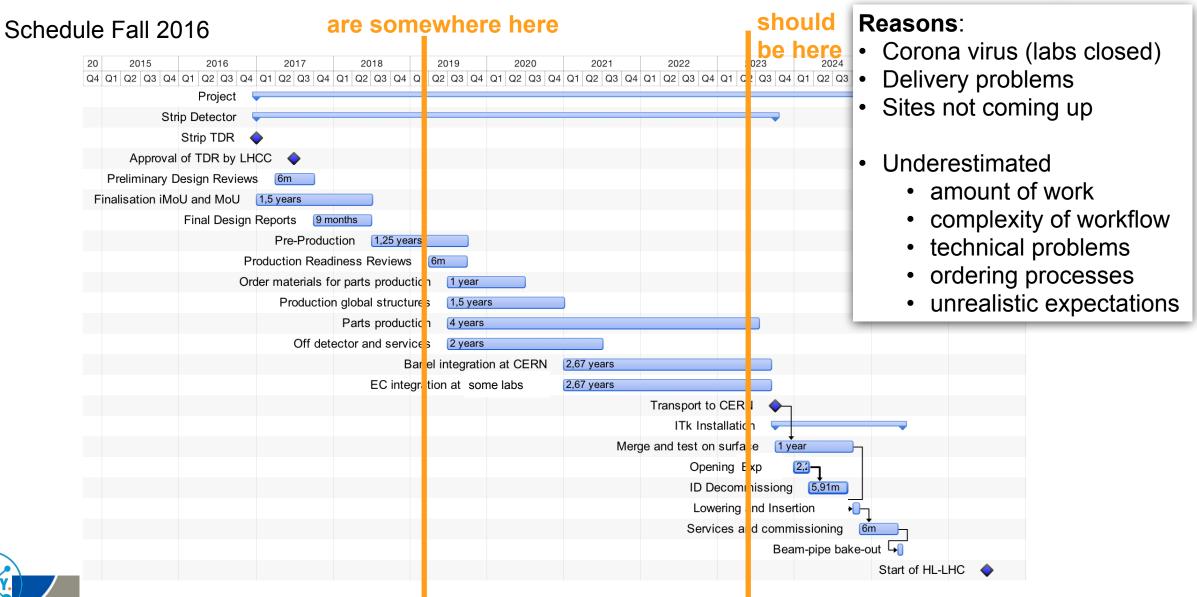


THE SCHEDULE

VI HOVET, S, C

600

AN EXAMPLE - UNKNOWN EXPERIMENT

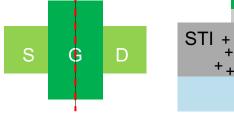


UNEXPECTED IRRADIATION FAILURE

VHOET, S, C

RADIATION DAMAGE IN SILICON

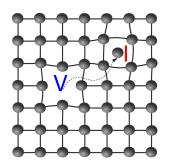
- Radiation damages the silicon on atomic level significantly leading to macroscopic effects.
- Surface effects: Generation of charge traps due to ionising energy loss — Total ionising dose, TID (problem for sensors and readout electronics).
 - Cumulative long term trapping of positive charge
 - Increase of leakage current and oxide breakdown



STI = shallow trench interface

p-substrate

- Bulk effects: displacement damage and build up of crystal defects due to non ionising energy loss (NIEL) (main problem for sensors).
 - Unit: 1MeV equivalent n/cm²



Defects composed of: Vacancies and Interstitials

Compound defects with impuritie possible!

- Transient effects: Radiation induced errors in microelectronic circuits
 - caused by passing charged particles leaving behind a wake of electron-hole pairs
 - single event upsets, single event latch-ups,

Generations of scientists worked on understanding failures connected to radiation damage and how to mitigated the effects - however ...



Ingrid-Maria Gregor - From Sensor to Detector

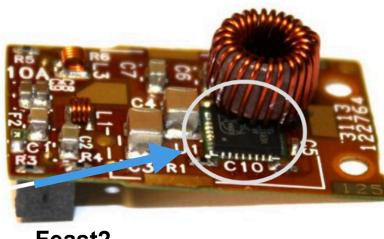
CMS DC-DC CONVERTER

- 2017 new pixel detector installed in CMS with DC-DC converter for powering
 - After few months: ~5% of deployed converters failed.
 - During winter shutdown: another ~35% of converters were found partially damaged
- Extremely difficult to identify problem
- Found strong correlation between radiation background and failures, as well as the functional sequence necessary for the damage to happen.
 - Damage caused by TID radiation damage opening a source-drain leakage current in **one** transistor in Feast2.1 chip
 - High-voltage transistors can not be designed in an enclosed layout to prevent this problem

during running

DC-DC in a nutshell:

transfer energy into detector with higher voltage/lower current and transform just before the load to operation voltage



Feast2

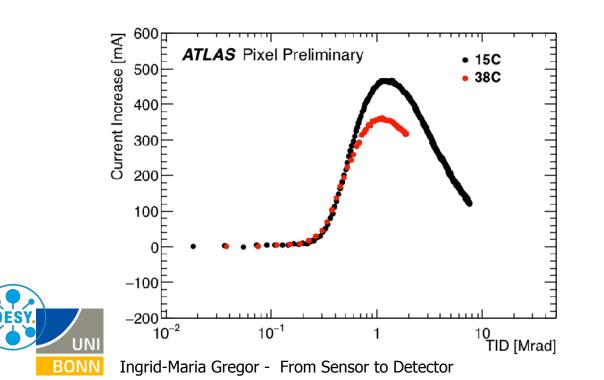
Consequences for operation
lower input voltage helps
stop disabling the output

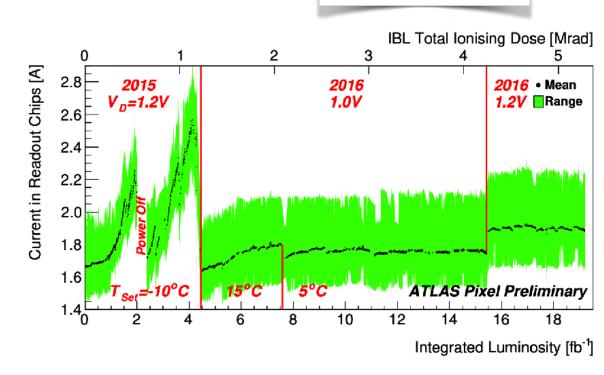


https://project-dcdc.web.cern.ch/project-dcdc/public/Documents/ExecutiveSummary2018.pdf https://instrumentationseminar.desy.de/sites2009/site_instrumentationseminar/content/e70397/e282395/e287407/20190614_pixelphase1JIS.pdf

ATLAS IBL TID BUMP

- Steep increase in power consumption of IBL during operation increasing the temperature
- Effect of total ionising dose on front-end chip FE-I4B
- Caused by the effect of TID on NMOS transistors:
 - Leakage current was induced by positive charge trapped in the bulk of the shallow trench isolation (STI)
 - Temperature and voltage depending





Mitigation plan:

- Operating temperature was increased from −10 ∘C to and 10 ∘C then decreased to 5 ∘C.
- Digital supply-voltage was decreased to from 1.2 V 1.0 V until TID approached more than 4 MRad.

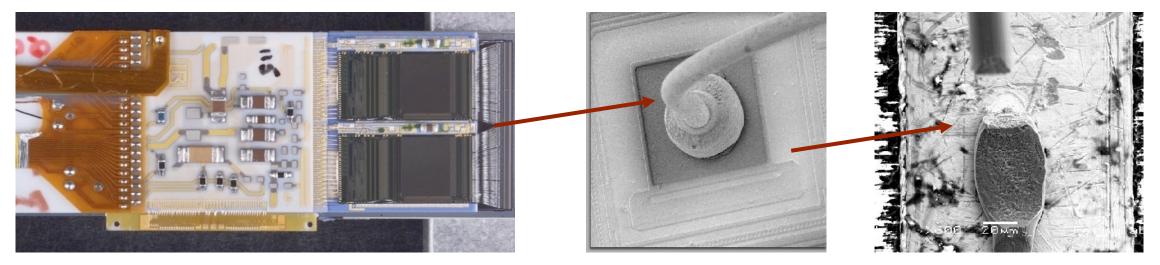
during running

WIRE-BONDS AND WIRE BREAKAGE

V HOET, S, C

PROBLEMS WITH WIRE BONDS (CDF, DO)

- Very important connection technology for tracking detectors: wire bonds:
 - 17-20 um small wire connection -> terrible sensitive
- Observation: During synchronous readout conditions, loss of modules (no data, Drop in current)



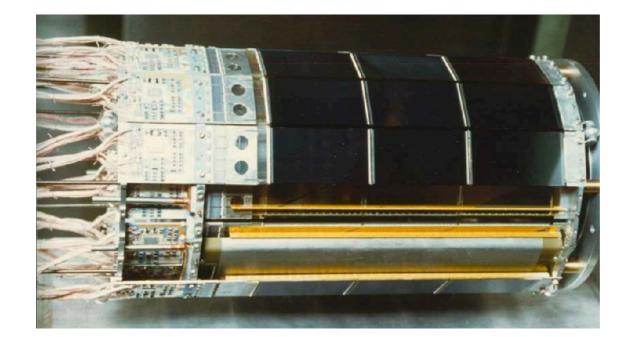
- Tests revealed:
 - Bonds start moving due to Lorentz Force in magnetic field
 - Wire resonance in the 20 kHz range
 - Current is highest during data readout
 - Already a few kicks are enough to get the bond excited

Implemented "Ghostbuster" system which avoids long phases with same readout frequency

during running

OPAL MVD 1994

- OPAL MVD ran for a short while without cooling water flow.
- Temperature of the detector rose to over 100°C.
 - Most of the modules to fail or to be partially damaged.
 - Chain of problem causing damage:



- MVD expert modified the control/monitoring software between consecutive data taking runs.
- Inserted bug which stopped software in a state with cooling water off but with the low voltage power on.
- Stopped software also prevented the monitoring of the temperature from functioning
- Should have been prevented by additional interlock but that was also disabled....

Lucky outcome:

- Damage was mostly melted wire bonds
- Detector could be fixed in winter shutdown

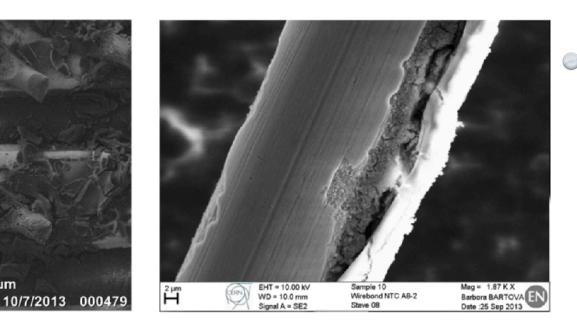
Mitigation plan:

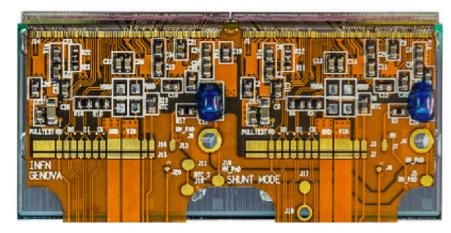
- new and more rigorous interlock system that could not be in a disabled state during data taking conditions.
- rule was implemented that prohibited software modifications between consecutive data taking runs.



ATLAS IBL - WIRE BOND CORROSION

- Additional pixel layer for ATLAS installed in 2015
- Five months before installation: corrosion residues observed at wire-bonds after cold tests (-25 C)
 - Severe damage of many wire-bonds
- Residue showed traces of chlorine: catalyst of a reaction between Aluminium (wire-bonds) and H₂O (in air)
- Origin of chlorine in system never fully understood





Emergency repair and additional staves from spare parts

during	production

https://indico.cern.ch/event/435798/contributions/1074098/attachments/1134177/1622192/encapsulation_study - Oxford.pdf

BONN Ingrid-Maria Gregor - From Sensor to Detector

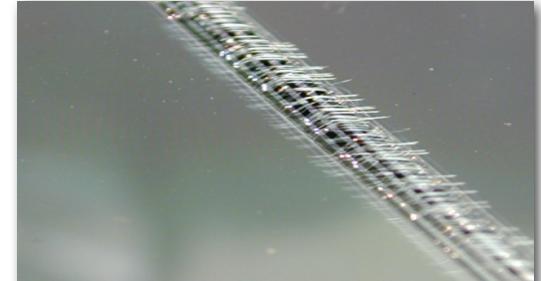
Vac-Low PC-Std. 10 kV

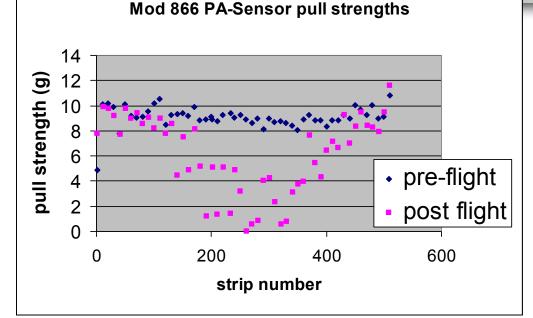
MORE WIRE BOND WRECKAGE

- During CMS strip tracker production quality assurance applied before and after transport
 - Quality of wires is tested by pull tests (measured in g)
- Wire bonds were weaker after transport with plane
- Random 3.4 g NASA vibration test could reproduce same problem
- Problem observed during production -> improved by adding a glue layer
- No further problems during production

during production







COOLING DAMAGES

VI FIDET, S, C

CCP.

WATER DAMAGE IN TRACKER ...

H1@HERA FST in 2004

- Imperfect crimp + hardening of plastic (age, irradiation) => water leak
- Water condensation => damage
- Tracker segment had to be rebuilt

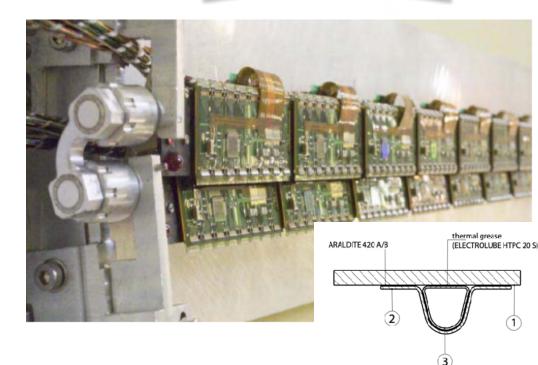
during running



ATLAS PIXEL TUBE CORROSION

during production

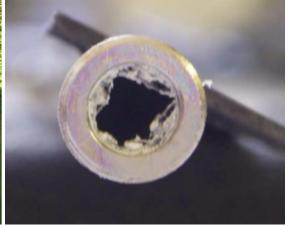
- Cooling tube of current pixel layers were supposed to be very light in material
 - Bare pipe material (AI)
 - Ni plating used to allow for brazing of the pipe fittings
 - No proper drying procedure \rightarrow water
- Water triggered corrosion process in the aluminium pipes.
 - Corrosion was due to galvanic process where water and traces of halogen (like CI) acted as electrolyte.
 - Effect of the galvanic corrosion led in some cases to holes in the pipe.





BONN





Six months delay in schedule

- Repair the 43 loaded staves with a pipe-inside-the-pipe
- Production of new staves with new Al compound and laser welding
- Repair of bare staves (~100)

PROBLEMS WITH MECHANICS

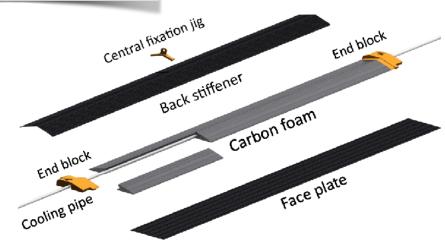
VI FIDET, S, C

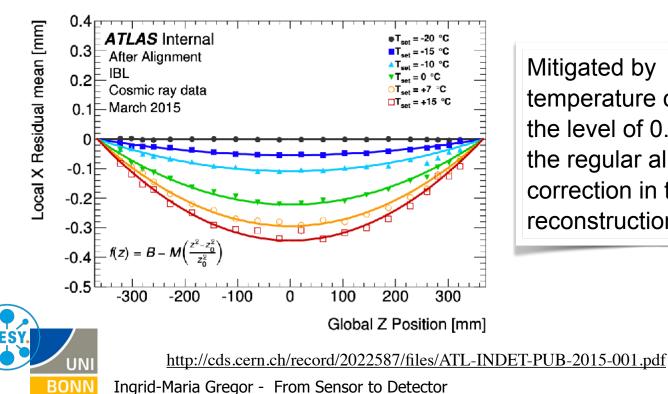
6001

ATLAS IBL STAVE BOW

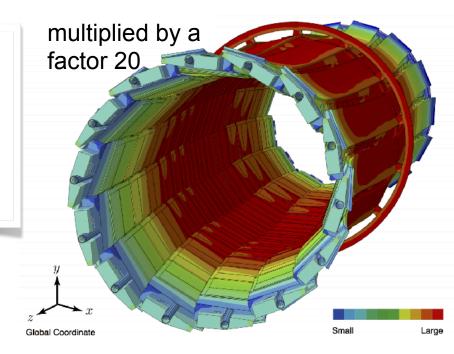
during commissioning

- Distortion depending on the operating temperature was observed.
- Caused by a mismatch between the coefficients of thermal expansion (CTE) of a bare stave made with the carbon foam and the flex attached on the bare stave.
- Maximum more than 300 µm at -20 °C with respect to the nominal position at the room temperature.





Mitigated by temperature control at the level of 0.2 K and the regular alignment correction in the offline reconstruction



CONCLUSIONS

- Building a detector is super complicated like building a death star
- Scaling from one module to thousands is not trivial
- Spend enough time on simulating all aspects of your detector with ALL materials implemented
- Don't underestimate the "low tech"
 - Cables
 - Cooling
 - Mechanics including FEA
 - Radiation damage of non-sensitive materials
 -
- Make sure the overall timeline is not completely crazy (tough job)
- When mixing materials ask a chemist once in a while



Solving and preventing theses kind of problems is also part of the fascination of detector physics!!

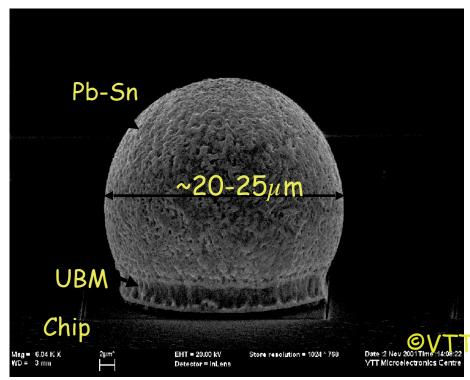


BACKUP

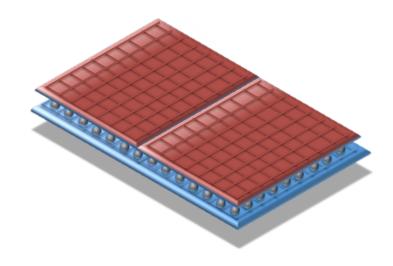
V HOVET, S, C

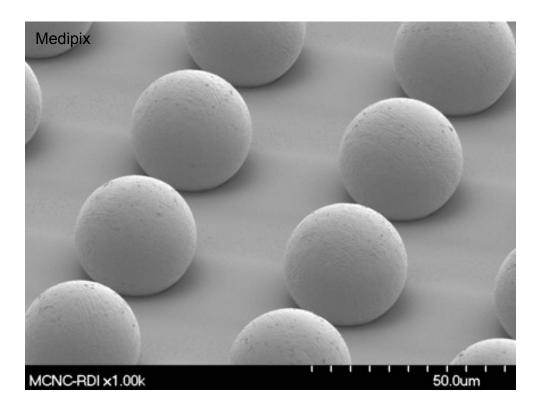
600

BUMP BONDS



SEM picture of one Pb-Sn bump bond





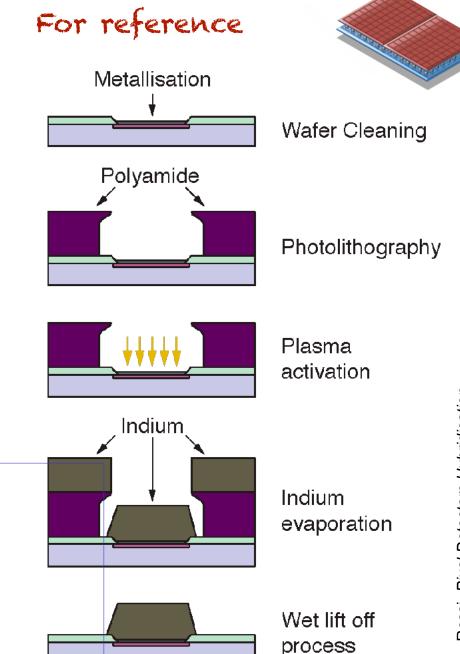


Ingrid-Maria Gregor - From Sensor to Detector

BUMP BONDING PROCESS

A typical bump bonding process (array bump bonding) is the following:

- 1. Deposition of an "underbump metal layer", plasma activated, for a better adhesion of the bump material.
- 2. Photolithography to precisely define areas for the deposition of the bond material.
- 3. Deposition, by evaporation, of the bond material (e.g. In or SnPb) producing little "bumps" ($\approx 10 \ \mu$ m height).
- 4. Edging of photolithography mask leaves surplus of bump metal on pads.
- 5. Reflow to form spheres.





Process parameters:

- Resist Thickness: 15 µm
- Pre-bake: 30min @ 80 °C
- Deposition rate: 0.5 µm/min
- Dep. Pressure: 9 x 10 7 Torr
- Temp. during Dep. < 50 °C

L. Rossi, *Pixel Detectors Hybridisation*, Nucl. Instr. Meth. A **501**, 239 (2003)

TID BUMP

Surface effects: Generation of charge traps due to ionizing energy loss (Total ionising dose, TID) (main problem for electronics).

- The leakage current is the sum of different mechanisms involving:
 - the creation/trapping of charge (by radiation)
 - its passivation/de-trapping (by thermal excitation)
- These phenomena are dose rate and temperature dependen
- Charge trapped in the STI oxide
 - +Q charge
 - Fast creation
 - Annealing already at T_{amb}
- Interface states at STI-Silicon interface
 - -Q for NMOS, +Q for PMOS
 - Slow creation
 - Annealing starts at 80-100C



